

# XP162A01B5PR



## Power MOS FET

- ◆P-Channel Power MOS FET
- ◆DMOS Structure
- ◆Low On-State Resistance: 0.25Ω (max)
- ◆Ultra High-Speed Switching
- ◆SOT-89 Package

## Applications

- Notebook PCs
- Cellular and portable phones
- On-board power supplies
- Li-ion battery systems

## General Description

The XP162A01B5PR is a P-Channel Power MOS FET with low on-state resistance and ultra high-speed switching characteristics.

Because high-speed switching is possible, the IC can be efficiently set thereby saving energy.

The small SOT-89 package makes high density mounting possible.

## Features

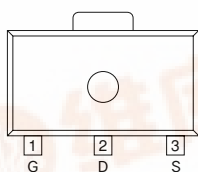
**Low on-state resistance:** Rds(on)=0.25Ω(Vgs=-4.5V)  
: Rds(on)=0.4Ω(Vgs=-2.5V)

**Ultra high-speed switching**

**Operational Voltage** : -2.5V

**High density mounting** : SOT-89

## Pin Configuration



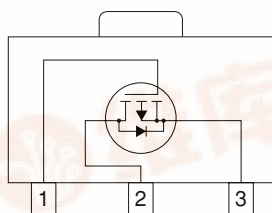
SOT-89  
(TOP VIEW)

## Pin Assignment

PIN NUMBER	PIN NAME	FUNCTION
1	G	Gate
2	D	Drain
3	S	Source

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## Equivalent Circuit



P-Channel MOS FET  
(1 device built-in)

## Absolute Maximum Ratings

Ta=25℃

PARAMETER	SYMBOL	RATINGS	UNITS
Drain-Source Voltage	Vdss	-20	V
Gate-Source Voltage	Vgss	±12	V
Drain Current (DC)	Id	-2	A
Drain Current (Pulse)	Idp	-6	A
Reverse Drain Current	Idr	-2	A
Continuous Channel Power Dissipation (note)	Pd	2	W
Channel Temperature	Tch	150	℃
Storage Temperature	Tstg	-55~150	℃

Note: When implemented on a ceramic PCB



## Electrical Characteristics

### DC Characteristics

 $T_a=25^{\circ}\text{C}$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Drain Cut-off Current	$I_{dss}$	$V_{ds}=-20\text{V}, V_{gs}=0\text{V}$			-10	$\mu\text{A}$
Gate-Source Leakage Current	$I_{gss}$	$V_{gs}=\pm 12\text{V}, V_{ds}=0\text{V}$			$\pm 10$	$\mu\text{A}$
Gate-Source Cut-off Voltage	$V_{gs(off)}$	$I_d=-1\text{mA}, V_{ds}=-10\text{V}$	-0.5			V
Drain-Source On-state Resistance (note)	$R_{ds(on)}$	$I_d=-1\text{A}, V_{gs}=-4.5\text{V}$		0.19	0.25	$\Omega$
		$I_d=-1\text{A}, V_{gs}=-2.5\text{V}$		0.3	0.4	$\Omega$
Forward Transfer Admittance (note)	$ Y_{fs} $	$I_d=-1\text{A}, V_{ds}=-10\text{V}$		2.5		S
Body Drain Diode Forward Voltage	$V_f$	$I_f=-2\text{A}, V_{gs}=0\text{V}$		-0.85	-1.1	V

Note: Effective during pulse test.

### Dynamic Characteristics

 $T_a=25^{\circ}\text{C}$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Capacitance	$C_{iss}$	$V_{ds}=-10\text{V}, V_{gs}=0\text{V}$ $f=1\text{MHz}$		320		pF
Output Capacitance	$C_{oss}$			180		pF
Feedback Capacitance	$C_{rss}$			65		pF

### Switching Characteristics

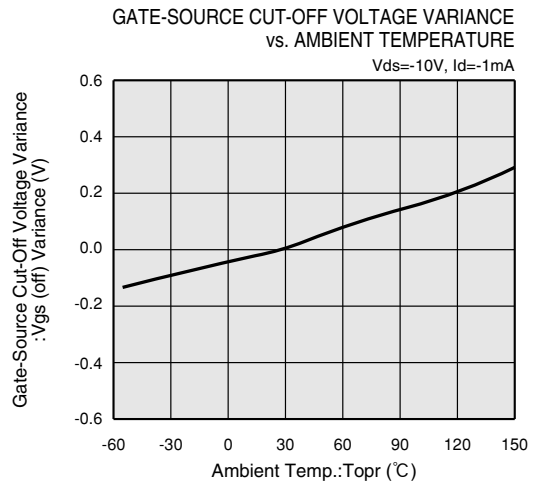
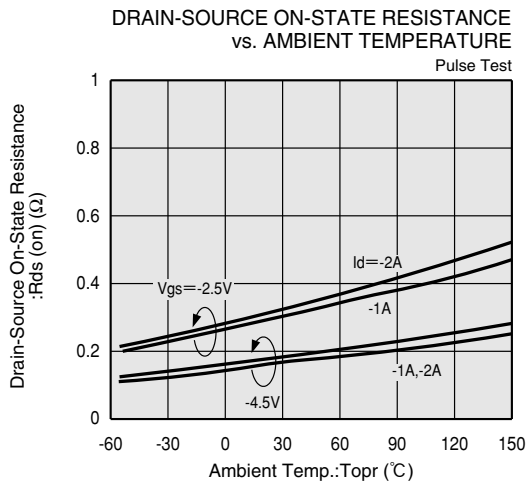
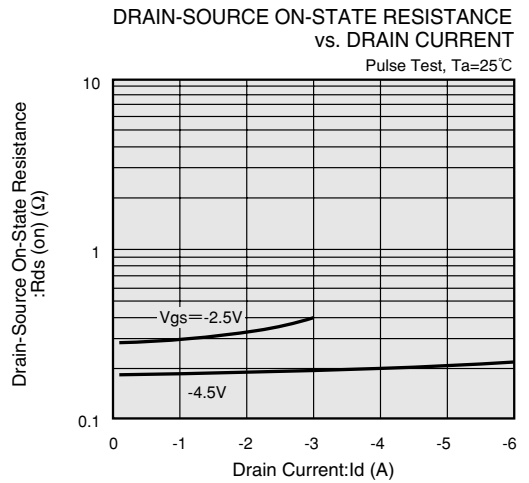
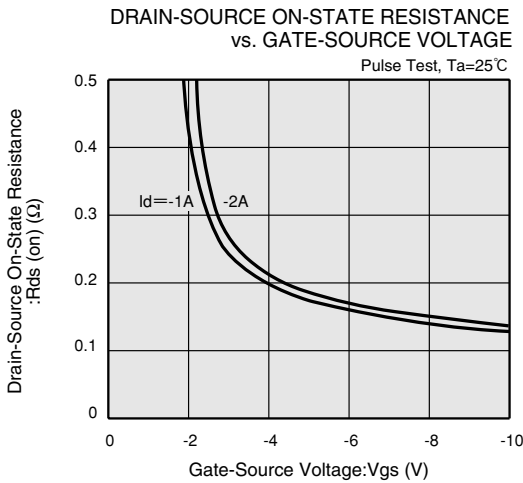
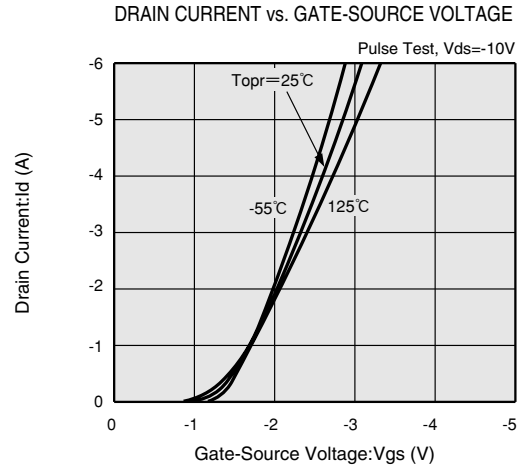
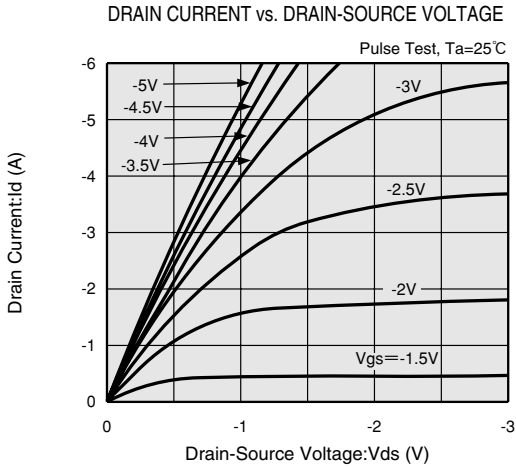
 $T_a=25^{\circ}\text{C}$ 

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
Turn-on Delay Time	$t_d(on)$	$V_{gs}=-5\text{V}, I_d=-1\text{A}$ $V_{dd}=-10\text{V}$		10		ns	
Rise Time	$t_r$			15		ns	
Turn-off Delay Time	$t_d(off)$				40		ns
Fall Time	$t_f$				50		ns

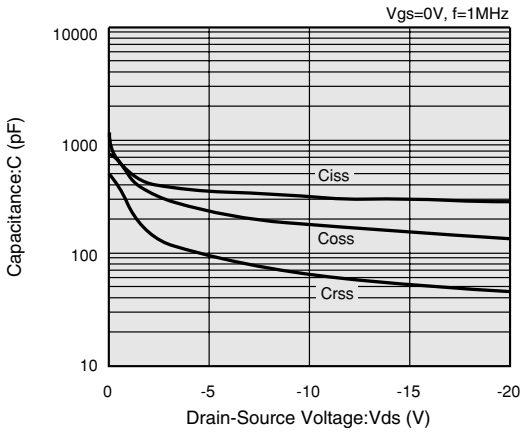
### Thermal Characteristics

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Thermal Resistance (channel-ambience)	$R_{th}(ch-a)$	Implement on a ceramic PCB		62.5		$^{\circ}\text{C/W}$

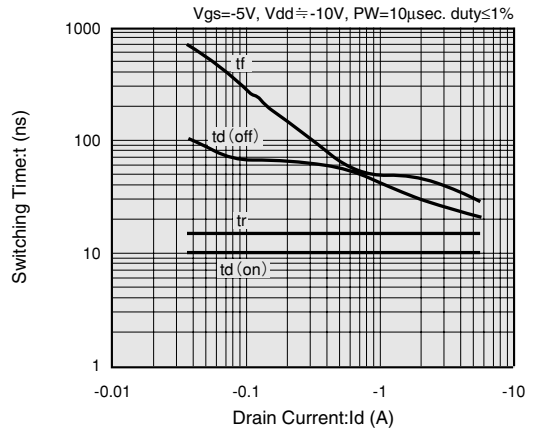
## Typical Performance Characteristics



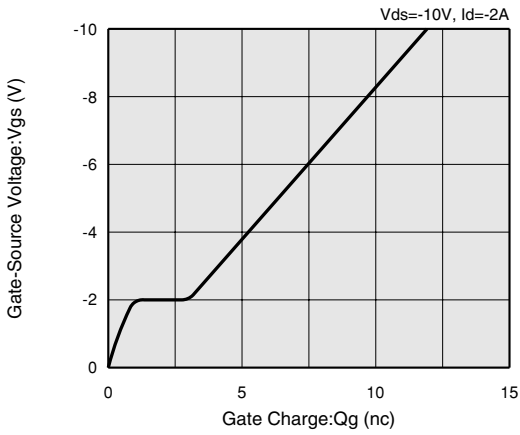
CAPACITANCE vs. DRAIN-SOURCE VOLTAGE



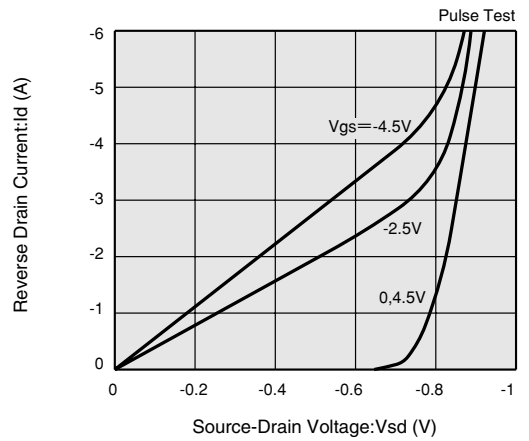
SWITCHING TIME vs. DRAIN CURRENT



GATE-SOURCE VOLTAGE vs. GATE CHARGE



REVERSE DRAIN CURRENT vs. SOURCE-DRAIN VOLTAGE



STANDARDIZED TRANSITION THERMAL RESISTANCE vs. PULSE WIDTH

